

2nd Generation thinQ!TM SiC Schottky Diode

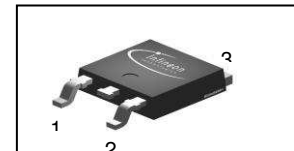
Features

- Revolutionary semiconductor material - Silicon Carbide
- Switching behavior benchmark
- No reverse recovery/ No forward recovery
- No temperature influence on the switching behavior
- High surge current capability
- Pb-free lead plating; RoHS compliant
- Qualified according to JEDEC¹⁾ for target applications
- Breakdown voltage tested at 20mA²⁾
- Optimized for high temperature operation

Product Summary

V_{DC}	600	V
Q_c	8	nC
I_F	4	A

PG-TO252



thinQ! 2G Diode specially designed for fast switching applications like:

- SMPS e.g.; CCM PFC; typ P_{out} = 400 - 800W
- Motor Drives; Solar applications; UPS

Type	Package	Marking	Pin 1	Pin 2	Pin 3
IDD04S60C	PG-TO252	D04S60C	n.c.	A	C

Maximum ratings

Parameter	Symbol	Conditions	Value	Unit
Continuous forward current	I_F	$T_C < 130\text{ °C}$	4	A
		$T_C < 100\text{ °C}$	6	
RMS forward current	$I_{F,RMS}$	$f = 50\text{ Hz}$	5.6	
Surge non-repetitive forward current, sine halfwave	$I_{F,SM}$	$T_C = 25\text{ °C}, t_p = 10\text{ ms}$	32.6	
Repetitive peak forward current	$I_{F,RM}$	$T_j = 150\text{ °C}, T_C = 100\text{ °C}, D = 0.1$	19.6	
Non-repetitive peak forward current	$I_{F,max}$	$T_C = 25\text{ °C}, t_p = 10\text{ }\mu\text{s}$	200	
i^2t value	$\int i^2 dt$	$T_C = 25\text{ °C}, t_p = 10\text{ ms}$	5.3	A ² s
Repetitive peak reverse voltage	V_{RRM}		600	V
Diode dv/dt ruggedness	dv/dt	$V_R = 0 \dots 480\text{ V}$	50	V/ns
Power dissipation	P_{tot}	$T_C = 25\text{ °C}$	42	W
Operating and storage temperature	T_j, T_{stg}		-55 ... 175	°C

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	

Thermal characteristics

Thermal resistance, junction - case	R_{thJC}		-	-	3.6	K/W
Thermal resistance, junction - ambient	R_{thJA}	SMD version, device on PCB, minimal footprint	-	-	75	
		SMD Version, device on PCB, 6 cm ² cooling ³⁾	-	-	50	
Soldering temperature reflowsoldering	T_{sold}	reflow MSL 3	-	-	260	°C

Electrical characteristics, at $T_j=25\text{ °C}$, unless otherwise specified
Static characteristics

DC blocking voltage	V_{DC}	$I_R=0.05\text{ mA}$	600	-	-	V
Diode forward voltage	V_F	$I_F=4\text{ A}, T_j=25\text{ °C}$	-	1.7	1.9	
		$I_F=4\text{ A}, T_j=150\text{ °C}$	-	2	2.4	
		$I_F=_\text{A}, T_j=25\text{ °C}$		1.9	2.1	
		$I_F=_\text{A}, T_j=150\text{ °C}$		2.3	2.9	
Reverse current	I_R	$V_R=600\text{ V}, T_j=25\text{ °C}$	-	0.5	50	µA
		$V_R=600\text{ V}, T_j=150\text{ °C}$	-	2	500	

AC characteristics

Total capacitive charge	Q_c	$V_R=400\text{ V}, I_F \leq I_{F,max}, di_F/dt=200\text{ A}/\mu\text{s}, T_j=150\text{ °C}$	-	8	-	nC
Switching time ⁴⁾	t_c		-	-	<10	ns
Total capacitance	C	$V_R=1\text{ V}, f=1\text{ MHz}$	-	130	-	pF
		$V_R=300\text{ V}, f=1\text{ MHz}$	-	20	-	
		$V_R=600\text{ V}, f=1\text{ MHz}$	-	20	-	

¹⁾ J-STD20 and JESD22

²⁾ All devices tested under avalanche conditions, for a time periode of 5ms at 20 mA.

³⁾ Device on 40mm*40mm*1.5mm epox PCB FR4 with 6cm² (one layer, 70µm thick) copper area for drain connection. PCB is vertikal with out blown air.

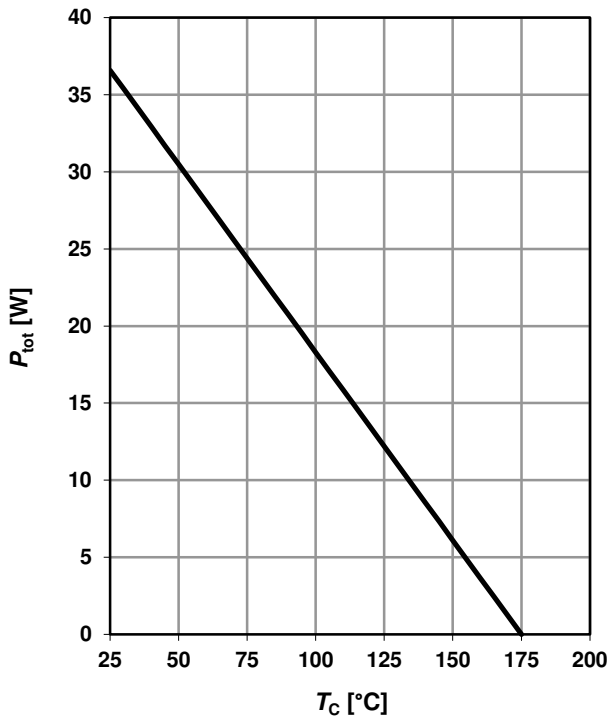
⁴⁾ t_c is the time constant for the capacitive displacement current waveform (independent from T_j, I_{LOAD} and di/dt), different from t_{rr} , which is dependent on $T_j, I_{LOAD}, di/dt$. No reverse recovery time constant t_{rr} due to absence of minority carrier injection.

⁵⁾ Only capacitive charge occuring, guaranteed by design.

⁶⁾ Repetitive condition defined by $T_j \leq 175\text{ °C}$

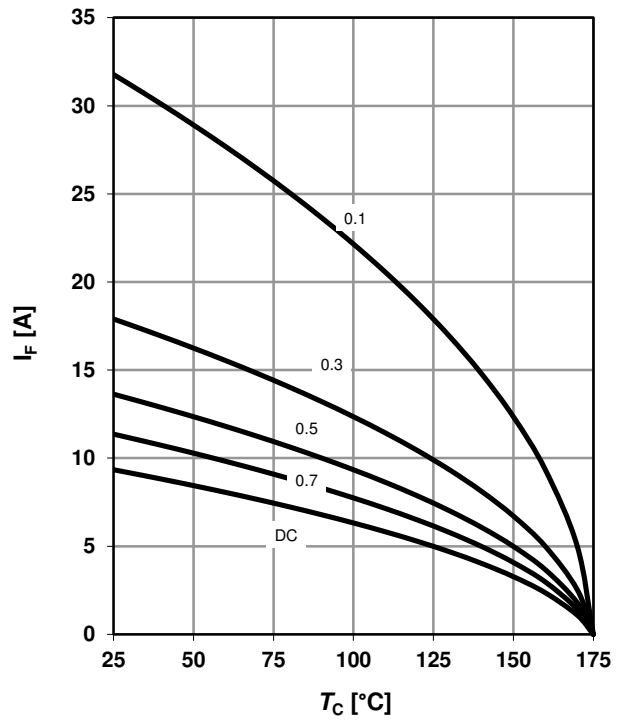
1 Power dissipation

$P_{tot}=f(T_C)$



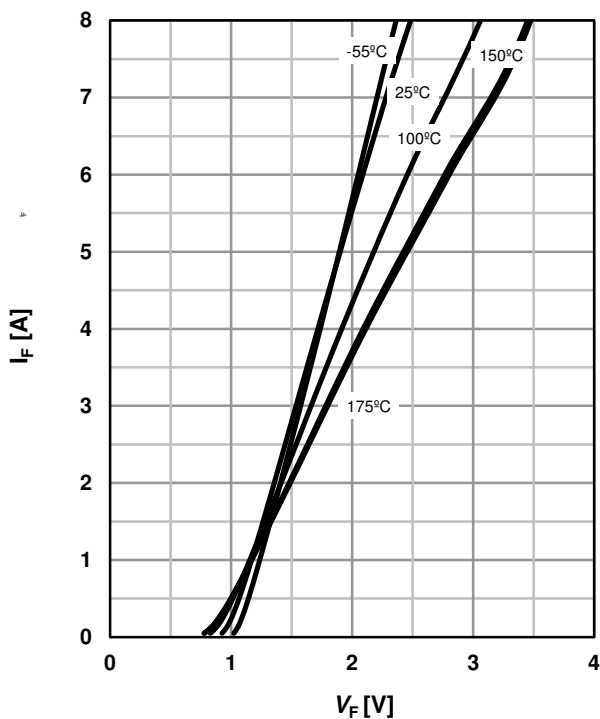
2 Diode forward current

$I_F=f(T_C)^4$; $T_j \leq 175\text{ °C}$; parameter: $D= t_p/T$



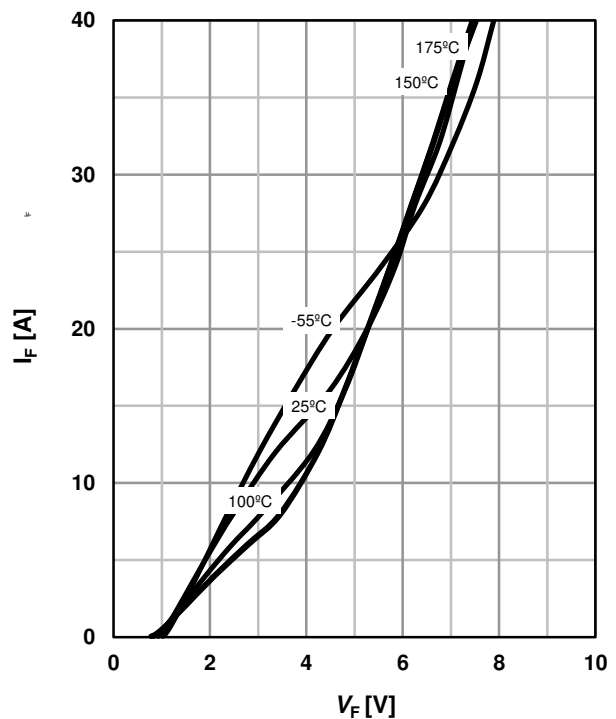
3 Typ. forward characteristic

$I_F=f(V_F)$; $t_p=400\text{ }\mu\text{s}$; parameter: T_j



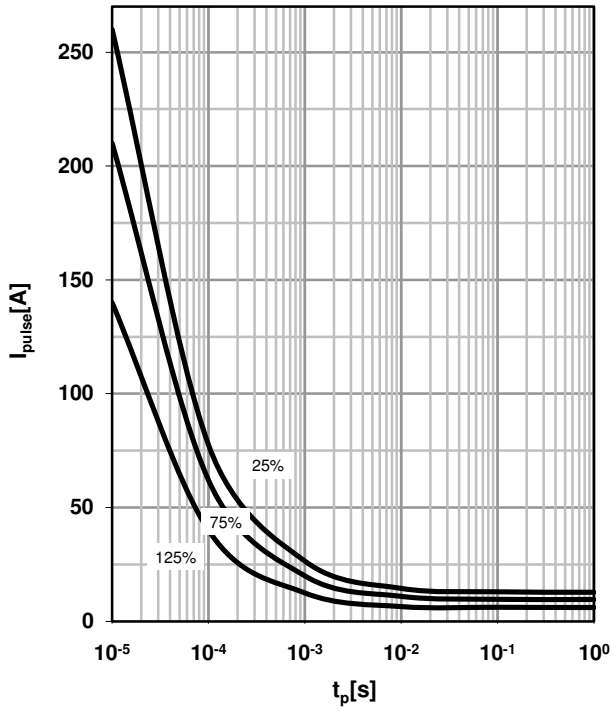
4 Typ. forward characteristic in surge current mode

$I_F=f(V_F)$; $t_p=400\text{ }\mu\text{s}$; parameter: T_j



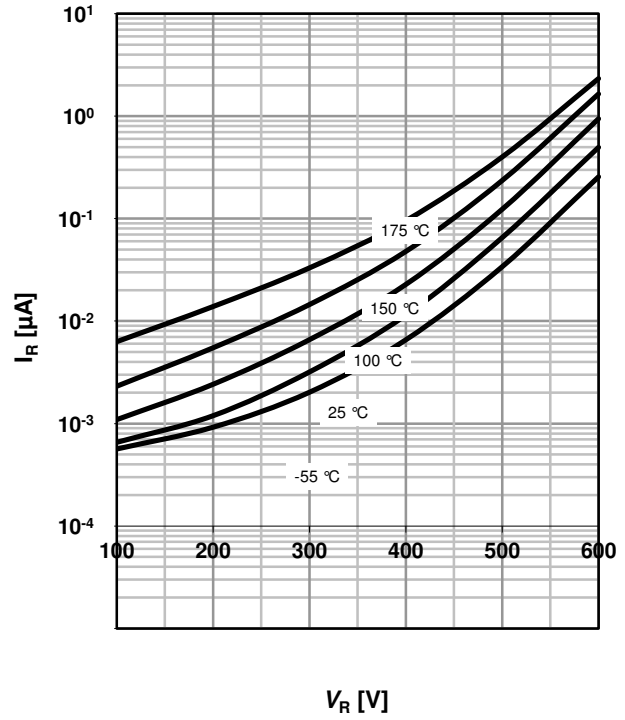
5 Max. repetitive pulse current

$I_{pulse}=f(t_p)^{4/5}$; parameter T_C



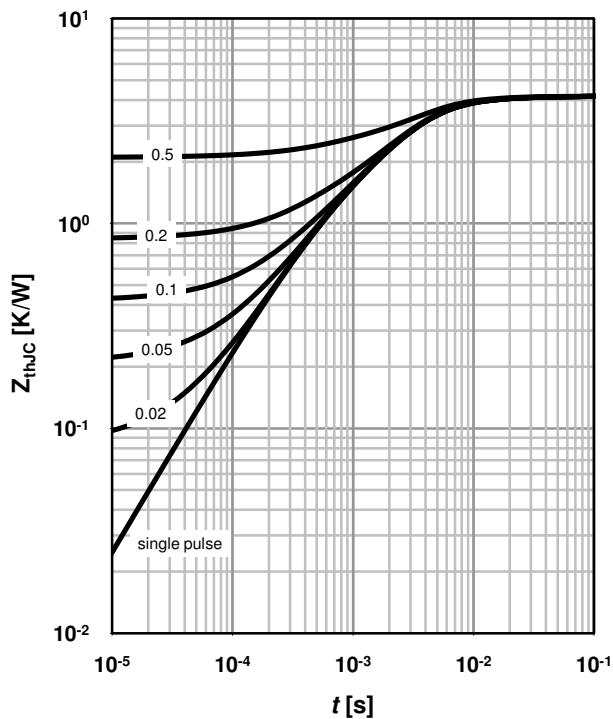
6 Typ. reverse current vs. reverse voltage

$I_R=f(V_R)$; parameter: T_j



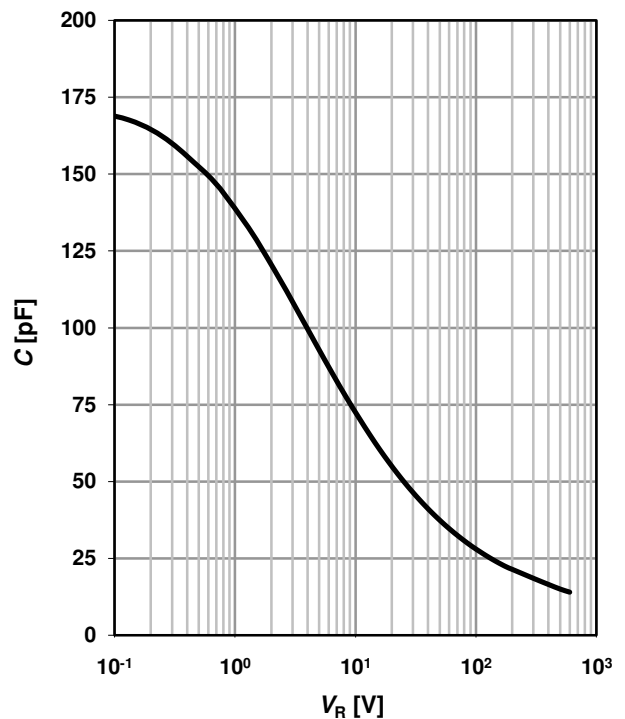
7 Transient thermal impedance

$Z_{thJC}=f(t_p)$; parameter: $D = t_p/T$



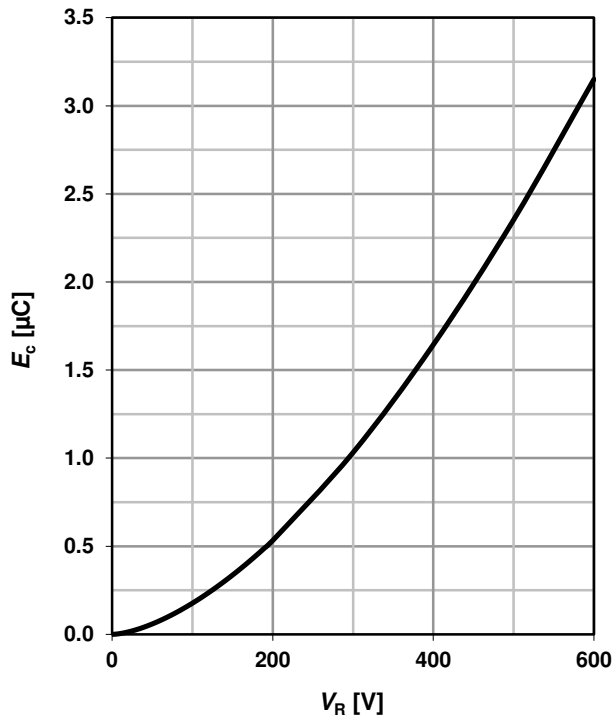
8 Typ. capacitance vs. reverse voltage

$C=f(V_R)$; $T_C=25\text{ °C}$, $f=1\text{ MHz}$



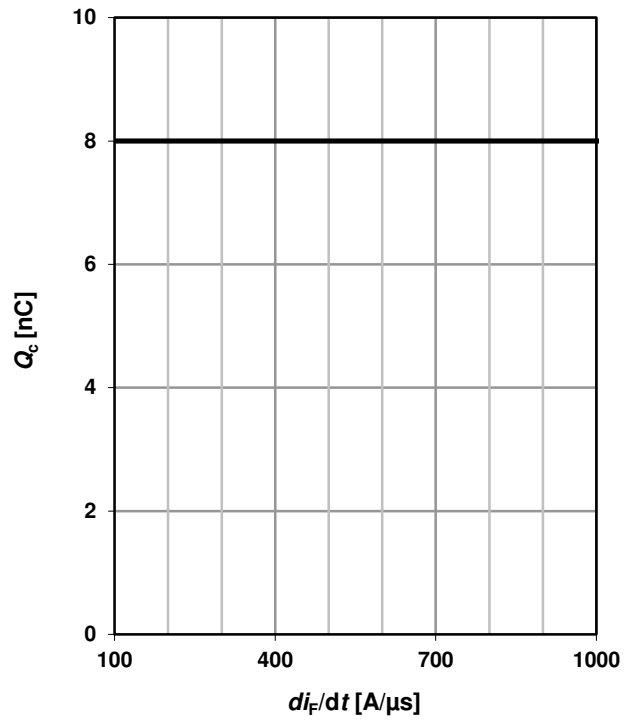
9 Typ. C stored energy

$$E_C = f(V_R)$$

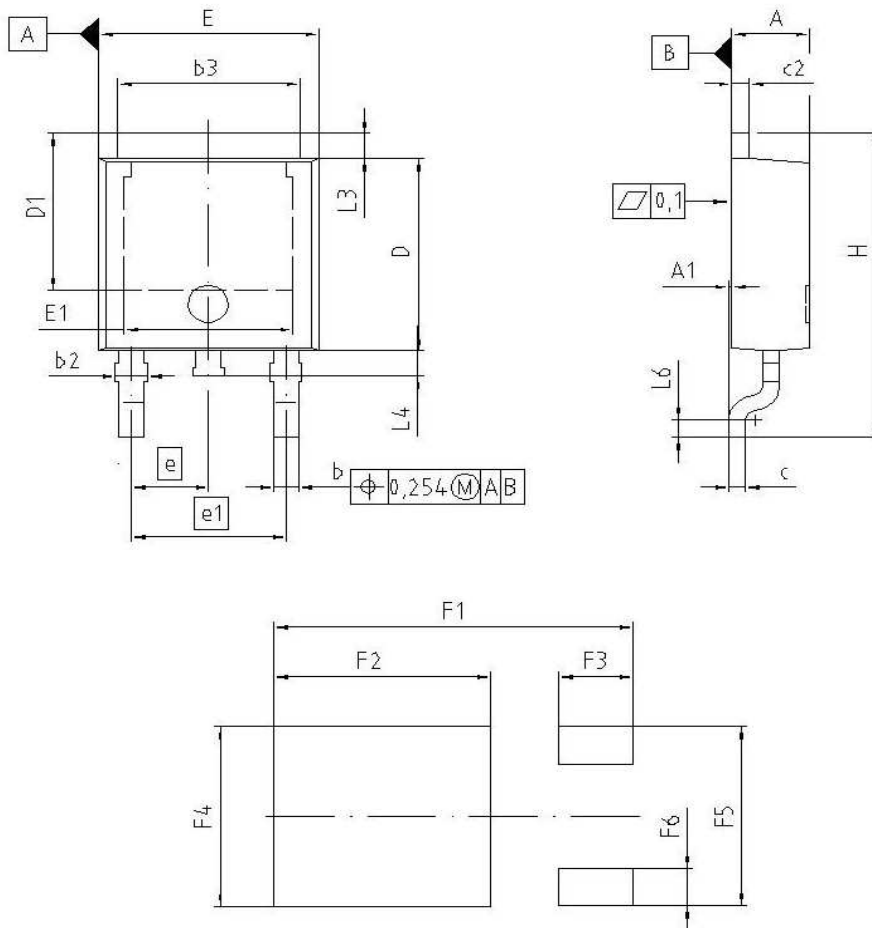


10 Typ. capacitance charge vs. current slope

$$Q_C = f(di_F/dt)^5; T_j = 150 \text{ }^\circ\text{C}; I_F \leq I_{F,max}$$



Package Outline:PG-TO252-3-1/TO252-3-11/TO252-3-21



DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	2.159	2.413	0.085	0.095
A1	0.000	0.150	0.000	0.006
b	0.635	0.889	0.025	0.035
b2	0.650	1.150	0.026	0.045
b3	5.004	5.500	0.197	0.217
c	0.457	0.580	0.018	0.023
c2	0.460	0.980	0.018	0.039
D	5.969	6.223	0.235	0.245
D1	5.020	5.842	0.198	0.230
E	6.400	6.731	0.252	0.265
E1	4.850	5.207	0.191	0.205
e	2.286		0.090	
e1	4.572		0.180	
N	3		3	
H	9.400	10.480	0.370	0.413
L3	0.900	1.143	0.035	0.045
L4	0.584	0.950	0.023	0.037
L6	0.510	0.686	0.020	0.027
F1	10.500	10.700	0.413	0.421
F2	6.300	6.500	0.248	0.256
F3	2.100	2.300	0.083	0.091
F4	5.700	5.900	0.224	0.232
F5	5.660	5.860	0.222	0.231
F6	1.100	1.300	0.043	0.051

REFERENCE
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SCALE

EUROPEAN PROJECTION

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